

Notice of References Cited	Application/Control No. <div style="text-align: center;">10/027,136</div>		Applicant(s)/Patent Under Reexam <div style="text-align: center;">Takayama et al</div>	
	Examiner <div style="text-align: center;">Aileen Felton</div>		Art Unit <div style="text-align: center;">3641</div>	Page 1 of 1

U.S. PATENT DOCUMENTS

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY¹</small>	Name	Classification ²	
A	6,019,861	2/2000	Canterberry et al	149	19.1
B	6,368,432	4/2002	Serizawa et al	149	46
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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